

# TEST REPORT

Report No.: BCTC2502262136E

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Applicant: Radxa Computer (Shenzhen) Co., Ltd.

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Product Name: Radxa CM5

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Test Model: Radxa CM5 D4E32R26

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Tested Date: 2025-02-20 to 2025-02-25

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Issued Date: 2025-02-25

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**Shenzhen BCTC Testing Co., Ltd.**



Product Name: Radxa CM5

Trademark: **radxa**<sup>®</sup>

Model/Type Reference: Radxa CM5 D4E32R26  
Radxa CM5 Lite D2E0R27, Radxa CM5 Lite D2E16R27, Radxa CM5 Lite D4E0R27, Radxa CM5 Lite D4E16R27, Radxa CM5 Lite D4E32R27, Radxa CM5 D4E0R26, Radxa CM5 D4E32R26, Radxa CM5 D8E0R26, Radxa CM5 D8E64R26, Radxa CM5 D16E0R26, Radxa CM5 D16E128R26, Radxa CM5 D32E0R26, Radxa CM5 D32E256R26

Prepared For: Radxa Computer (Shenzhen) Co., Ltd.

Address: 1602, Smart Valley, tiezai Road, Gongle community, Xixiang, Baoan, Shenzhen

Manufacturer: Radxa Computer (Shenzhen) Co., Ltd.

Address: 1602, Smart Valley, tiezai Road, Gongle community, Xixiang, Baoan, Shenzhen

Prepared By: Shenzhen BCTC Testing Co., Ltd.

Address: 1-2/F., Building B, Pengzhou Industrial Park, No.158, Fuyuan 1st Road, Zhancheng, Fuhai Subdistrict, Bao'an District, Shenzhen, Guangdong, China.

Sample Received Date: 2025-02-20

Sample Tested Date: 2025-02-20 to 2025-02-25

Issue Date: 2025-02-25

Report No.: BCTC2502262136E

Test Standards: FCC PART 15B  
ANSI C63.4:2014

Test Results: PASS

Tested by:



Icey Chen/ Project Handler

Approved by:



Zero Zhou/Reviewer

The test report is effective only with both signature and specialized stamp. This result(s) shown in this report refer only to the sample(s) tested. Without written approval of Shenzhen BCTC Testing Co., Ltd, this report can't be reproduced except in full. The tested sample(s) and the sample information are provided by the client.



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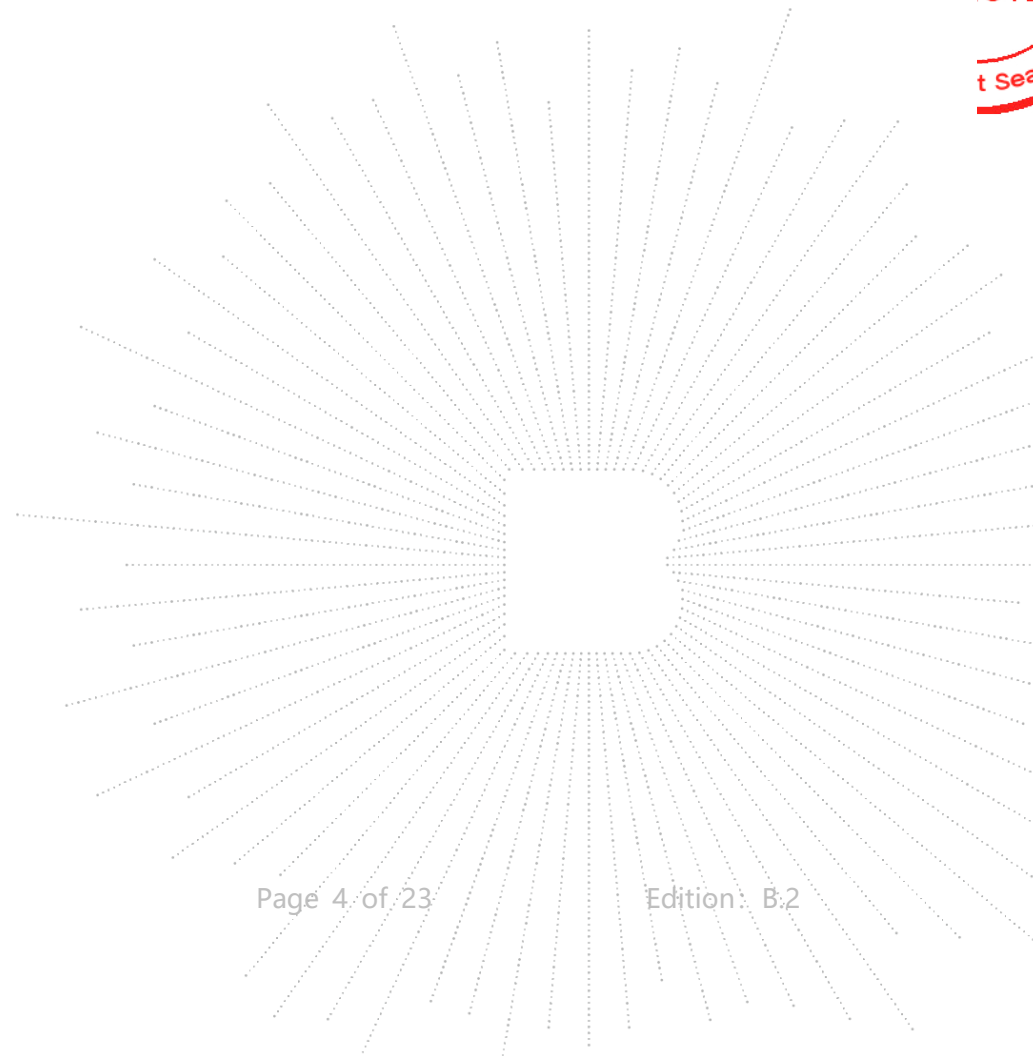
(Note: N/A Means Not Applicable)

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 Report

**1. Version**

Report No.	Issue Date	Description	Approved
BCTC2502262136E	2025-02-25	Original	Valid

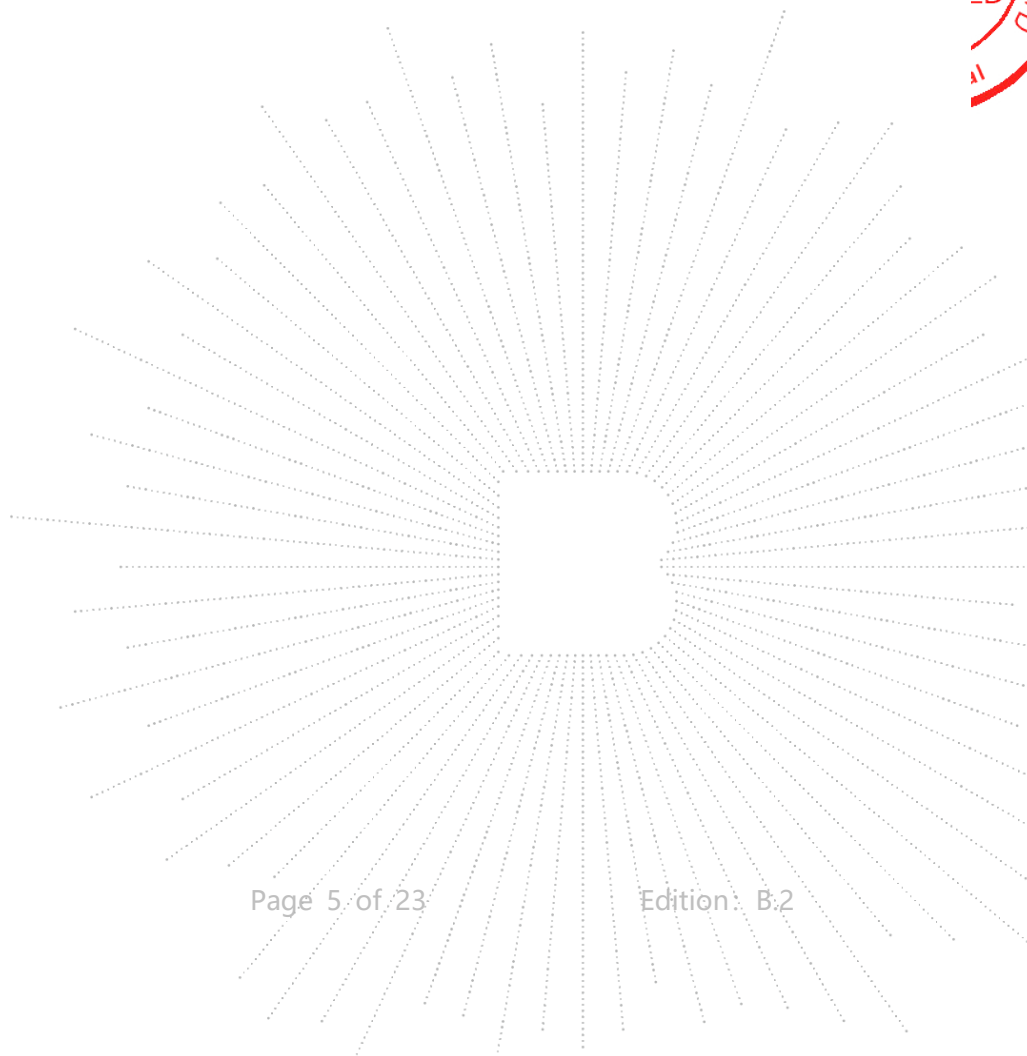
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## 2. Test Summary

The Product has been tested according to the following specifications:

Standard	Test Item	Test result
FCC 15.107	Conducted Emission	Pass
FCC 15.109	Radiated Emission	Pass



### 3. Measurement Uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the Product as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of  $k=2$ .

Test item	Value (dB)
Conducted Emission (150kHz-30MHz)	3.10
Radiated disturbance (30MHz-200MHz)	4.60
Radiated disturbance (200MHz-1000MHz)	5.20
Radiated disturbance (1GHz-6GHz)	5.20

CO., LTD.

## 4. Product Information And Test Setup

### 4.1 Product Information

**Ratings:** DC 12V 3A  
**Model difference:** All models are identical except for the appearance color and model named.  
**The highest frequency of the unintentional radiators internal sources of the EUT is (less than 108)MHz:**

- less than 1.705 MHz, the measurement shall only be made up to 30 MHz.
- between 1.705 MHz and 108 MHz, the measurement shall only be made up to 1 GHz.
- between 108 MHz and 500 MHz, the measurement shall only be made up to 2 GHz.
- between 500 MHz and 1 GHz, the measurement shall only be made up to 5 GHz.
- above 1 GHz, the measurement shall be made up to 5 times the highest frequency or 40GHz, whichever is less.

### 4.2 Test Setup Configuration

See test photographs attached in EUT TEST SETUP Photographs for the actual connections between Product and support equipment.

### 4.3 Support Equipment

No.	Device Type	Brand	Model	Series No.	Note
1.	Display	LG	27G93U	---	---
2.	U disk	SanDisk	32G	---	---
3.	Keyboard	Logitech	M-U0026	---	---
4.	Mouse	Logitech	YU0036	---	---

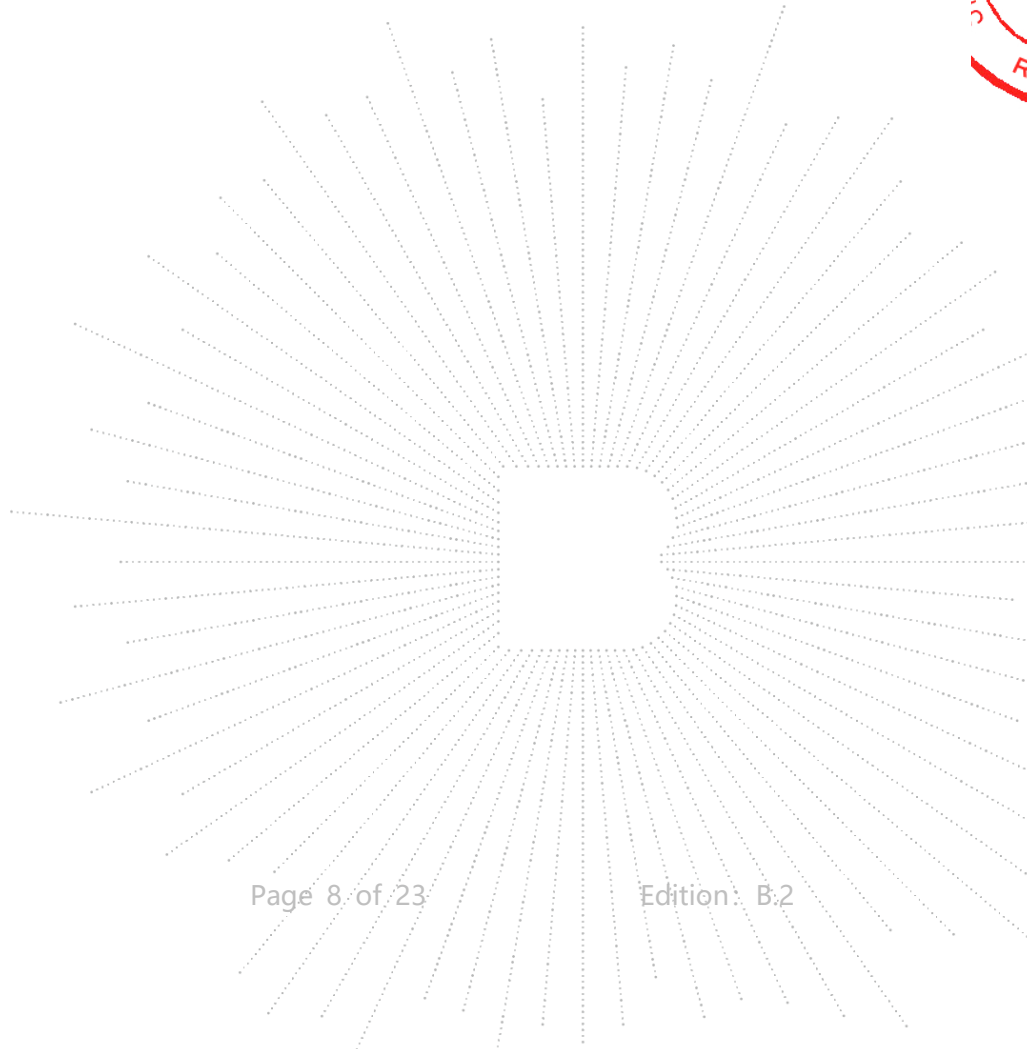
**Notes:**

- All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.
- Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.



## 4.4 Test Mode

Test item	Test Mode	Test Voltage
Conducted Emission (150KHz-30MHz) Class B	Working	DC 12V from adapter input AC 120V/60Hz
Radiated emission(30MHz-1GHz) Class B	Working	DC 12V from adapter input AC 120V/60Hz
Radiated emissions(1 – 6 GHz) <input type="checkbox"/> Class A <input checked="" type="checkbox"/> Class B	Working	DC 12V from adapter input AC 120V/60Hz





## 5. Test Facility And Test Instrument Used

### 5.1 Test Facility

All measurement facilities used to collect the measurement data are located at Shenzhen BCTC Testing Co., Ltd. Address: 1-2/F., Building B, Pengzhou Industrial Park, No.158, Fuyuan 1st Road, Zhancheng, Fuhai Subdistrict, Bao'an District, Shenzhen, Guangdong, China. The site and apparatus are constructed in conformance with the requirements of ANSI C63.4 and CISPR 16-1-1 other equivalent standards.

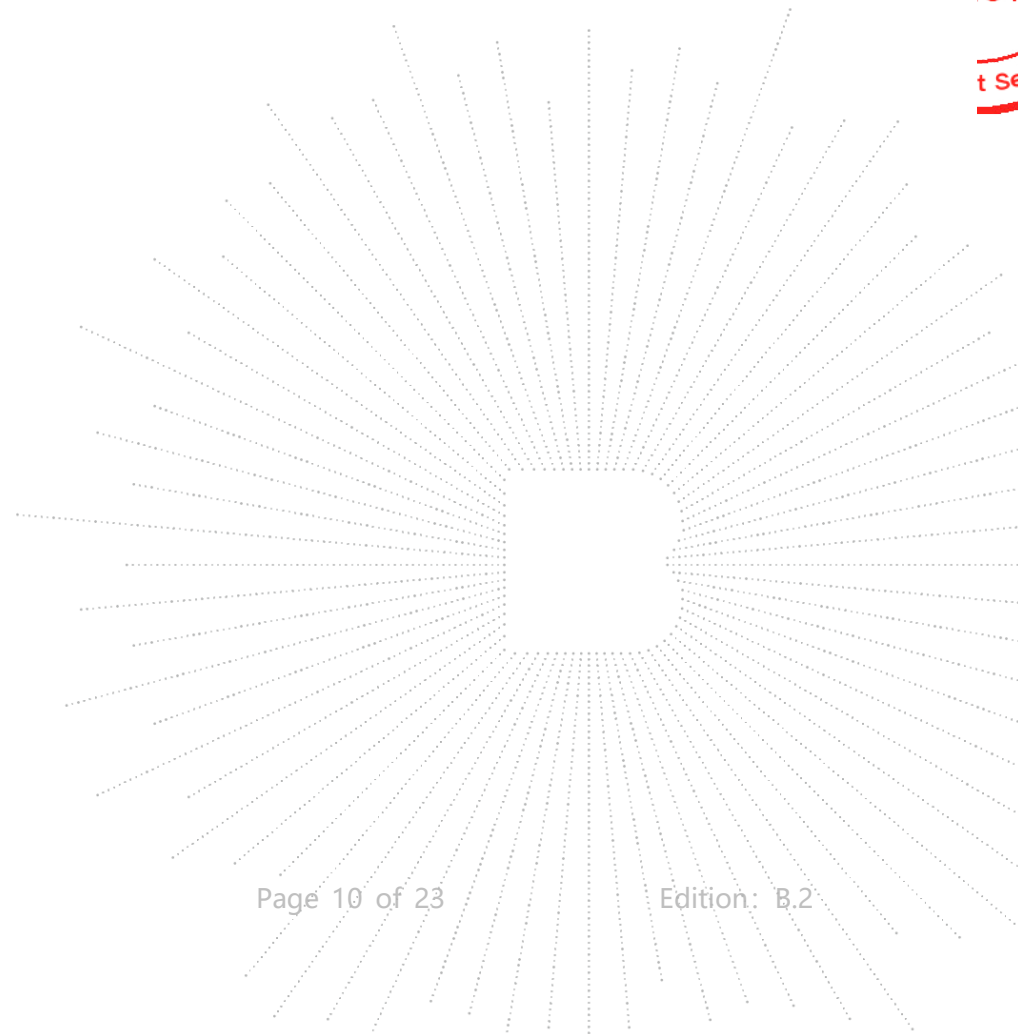
### 5.2 Test Instrument Used

Conducted Emissions Test					
Equipment	Manufacturer	Model#	Serial#	Last Cal.	Next Cal.
Receiver	R&S	ESR3	102075	May 16, 2024	May 15, 2025
LISN	R&S	ENV216	101375	May 16, 2024	May 15, 2025
Software	Frad	EZ-EMC	EMC-CON 3A1	\	\
Pulse limiter	Schwarzbeck	VTSD 9561-F	01323	May 16, 2024	May 15, 2025

Radiated Emissions Test (966 Chamber#01)					
Equipment	Manufacturer	Model#	Serial#	Last Cal.	Next Cal.
966 chamber	ChengYu	966 Room	966	May 15, 2023	May 14, 2026
Receiver	R&S	ESRP	101154	May 16, 2024	May 15, 2025
Receiver	R&S	ESR3	102075	May 16, 2024	May 15, 2025
Amplifier	SKET	LAPA_01G1 8G-45dB	SK2021040901	May 16, 2024	May 15, 2025
Amplifier	Schwarzbeck	BBV9744	9744-0037	May 16, 2024	May 15, 2025
TRILOG Broadband Antenna	schwarzbeck	VULB9163	942	May 21, 2024	May 20, 2025
Horn Antenna	schwarzbeck	BBHA9120D	1541	May 21, 2024	May 20, 2025
Software	Frad	EZ-EMC	FA-03A2 RE	\	\

Radiated Emissions Test (966 Chamber#02)					
Equipment	Manufacturer	Model#	Serial#	Last Cal.	Next Cal.
966 chamber	SKET	966 Room	966	Oct. 31. 2024	Oct. 30.2027
Receiver	R&S	ESR3	102075	May 16, 2024	May 15, 2025
Receiver	R&S	ESR17	100010	Oct. 31. 2024	Oct. 30. 2025
TRILOG Broadband Antenna	Schwarzbeck	VULB9168	1323	Feb. 28, 2024	Feb. 27, 2025
Amplifier	SKET	LNPA-30M01 G-30	SK2021082004	Oct. 31. 2024	Oct. 30. 2025
Software	SKET	EZ-EMC	FA-03A1	\	\
Horn Antenna	schwarzbeck	BBHA9120D	1541	May 21, 2024	May 20, 2025
Amplifier	SKET	LAPA_01G1 8G-45dB	SK2021040901	May 16, 2024	May 15, 2025

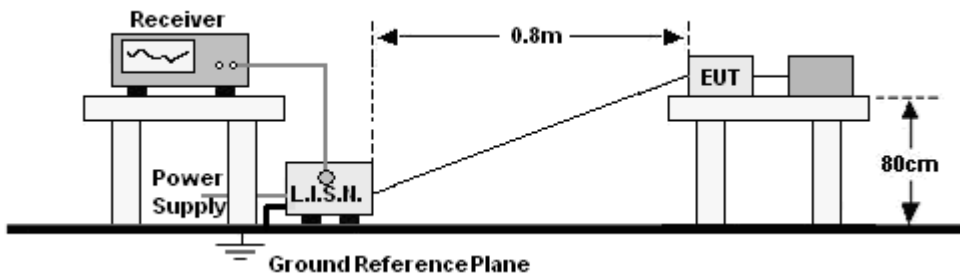
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## 6. Conducted Emission At The Mains Terminals Test

### 6.1 Block Diagram Of Test Setup

For mains ports:



### 6.2 Limit

Limits for Class B devices

Frequency range (MHz)	Limits dB( $\mu$ V)	
	Quasi-peak	Average
0,15 to 0,50	66 to 56*	56 to 46*
0,50 to 5	56	46
5 to 30	60	50

Notes: 1. \*Decreasing linearly with logarithm of frequency.  
2. The lower limit shall apply at the transition frequencies.

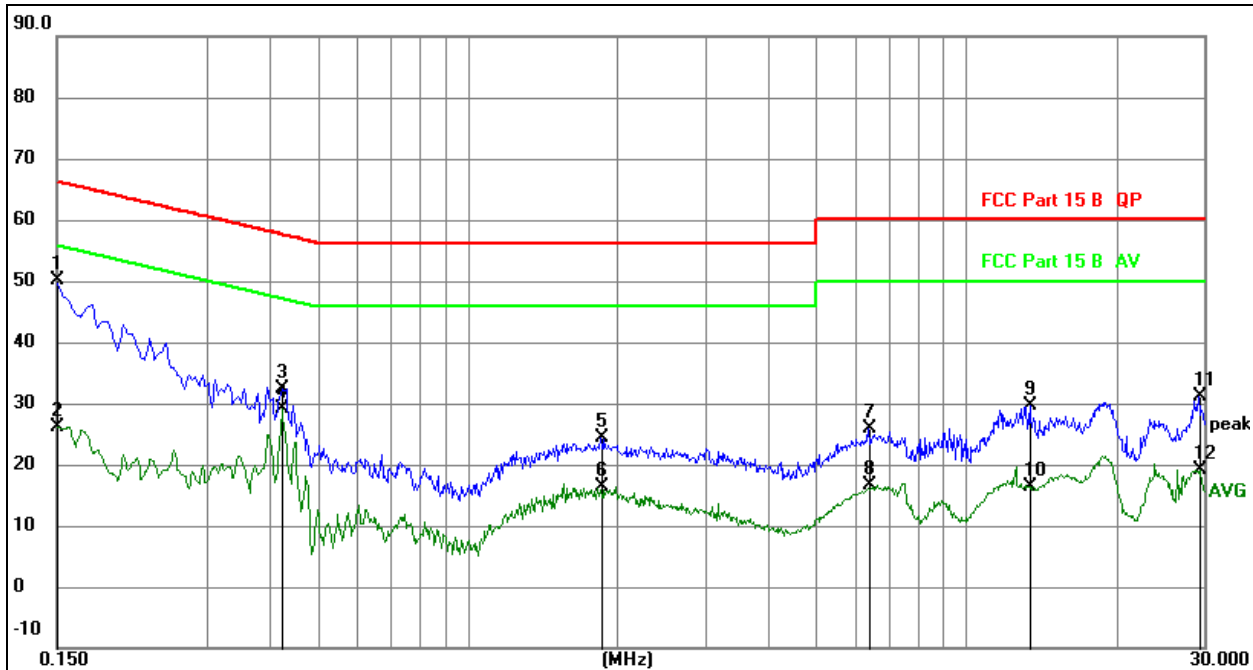
### 6.3 Test procedure

For mains ports:

- The Product was placed on a nonconductive table 0.8 m above the horizontal ground reference plane, and 0.4 m from the vertical ground reference plane, and connected to the main through Line Impedance Stability Network (L.I.S.N).
- The RBW of the receiver was set at 9 kHz in 150 kHz ~ 30MHz with Peak and AVG detector in Max Hold mode. Run the receiver's pre-scan to record the maximum disturbance generated from Product in all power lines in the full band.
- For each frequency whose maximum record was higher or close to limit, measure its QP and AVG values and record.

### 6.4 Test Result

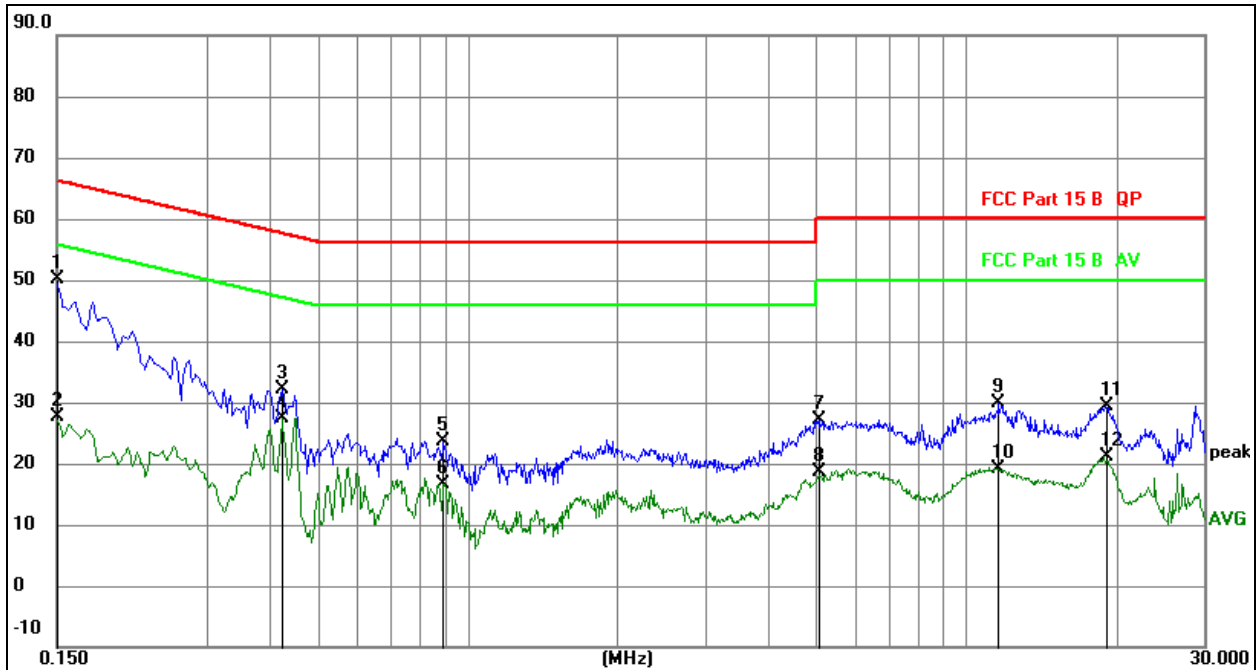
Temperature:	24.3 °C	Relative Humidity:	52%RH
Pressure:	101kPa	Phase :	Line
Test Voltage :	DC 12V from adapter input AC 120V/60Hz	Test Mode:	Working


**Remark:**

1. All readings are Quasi-Peak and Average values.
2. Factor = Insertion Loss + Cable Loss.
3. Measurement = Reading Level + Correct Factor.
4. Over = Measurement – Limit.

No.	Mk.	Freq. MHz	Reading Level	Correct Factor dB	Measure- ment dBuV	Limit dBuV	Over dB	Detector
1	*	0.1500	30.02	20.07	50.09	66.00	-15.91	QP
2		0.1500	6.10	20.07	26.17	56.00	-29.83	AVG
3		0.4245	12.20	20.08	32.28	57.36	-25.08	QP
4		0.4245	9.11	20.08	29.19	47.36	-18.17	AVG
5		1.8554	4.22	20.10	24.32	56.00	-31.68	QP
6		1.8554	-3.79	20.10	16.31	46.00	-29.69	AVG
7		6.3780	5.70	20.16	25.86	60.00	-34.14	QP
8		6.3780	-3.59	20.16	16.57	50.00	-33.43	AVG
9		13.4205	9.45	20.27	29.72	60.00	-30.28	QP
10		13.4205	-3.95	20.27	16.32	50.00	-33.68	AVG
11		29.3145	10.91	20.27	31.18	60.00	-28.82	QP
12		29.3145	-1.03	20.27	19.24	50.00	-30.76	AVG

Temperature:	24.3 °C	Relative Humidity:	52%RH
Pressure:	101kPa	Phase :	Neutral
Test Voltage :	DC 12V from adapter input AC 120V/60Hz	Test Mode:	Working


**Remark:**

1. All readings are Quasi-Peak and Average values.
2. Factor = Insertion Loss + Cable Loss.
3. Measurement = Reading Level + Correct Factor.
4. Over = Measurement – Limit.

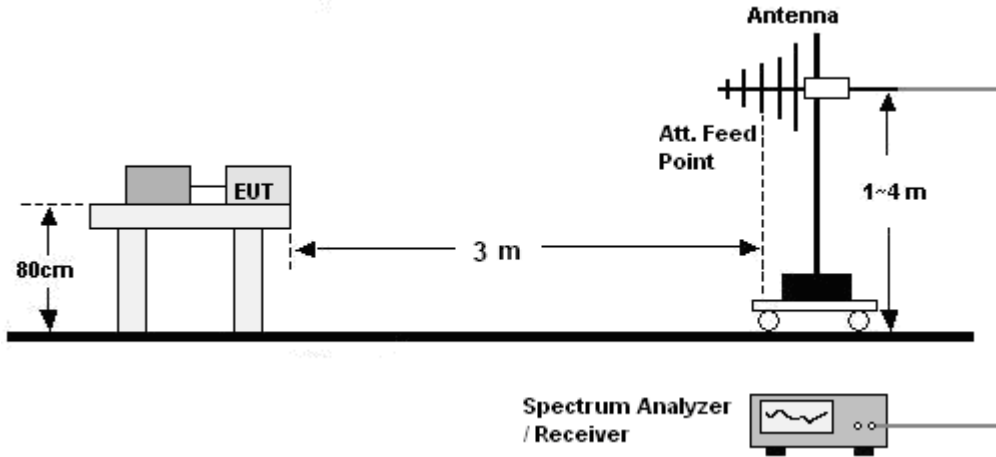
No.	Mk.	Freq. MHz	Reading Level	Correct Factor dB	Measure- ment dBuV	Limit dBuV	Over dB	Detector
1	*	0.1500	30.14	20.07	50.21	66.00	-15.79	QP
2		0.1500	7.60	20.07	27.67	56.00	-28.33	AVG
3		0.4237	12.02	20.08	32.10	57.38	-25.28	QP
4		0.4237	7.26	20.08	27.34	47.38	-20.04	AVG
5		0.8944	3.43	20.09	23.52	56.00	-32.48	QP
6		0.8944	-3.48	20.09	16.61	46.00	-29.39	AVG
7		5.0580	7.07	20.15	27.22	60.00	-32.78	QP
8		5.0580	-1.55	20.15	18.60	50.00	-31.40	AVG
9		11.6208	9.75	20.22	29.97	60.00	-30.03	QP
10		11.6208	-1.06	20.22	19.16	50.00	-30.84	AVG
11		19.0210	9.04	20.33	29.37	60.00	-30.63	QP
12		19.0210	0.74	20.33	21.07	50.00	-28.93	AVG

SHENZHEN

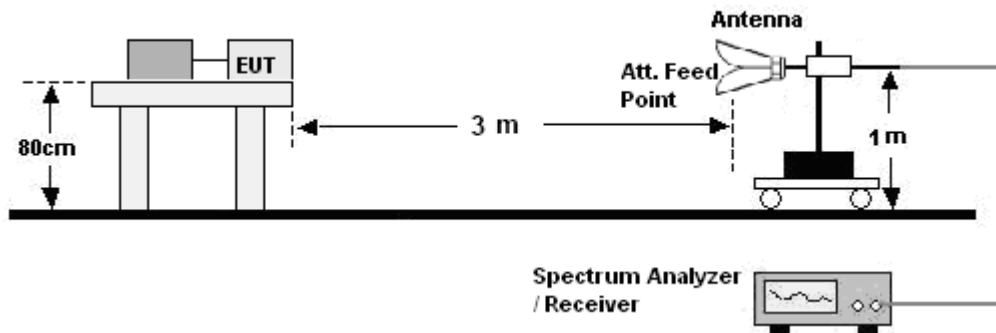
## 7. Radiation Emission Test

### 7.1 Block Diagram Of Test Setup

30MHz ~ 1GHz:



Above 1GHz:



### 7.2 Limit

Limits for Class B devices

Frequency (MHz)	limits at 3m dB( $\mu$ V/m)		
	QP Detector	PK Detector	AV Detector
30-88	40.0	--	--
88-216	43.5	--	--
216-960	46.0	--	--
960 to 1000	54.0	--	--
Above 1000	--	74.0	54.0

Note: The lower limit shall apply at the transition frequencies.

### 7.3 Test Procedure

#### 30MHz ~ 1GHz:

- a. The Product was placed on the nonconductive turntable 0.8 m above the ground at a chamber.
- b. Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 120 kHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied between 1~4 m in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.
- c. For each frequency whose maximum record was higher or close to limit, measure its QP value: vary the antenna's height and rotate the turntable from 0 to 360 degrees to find the height and degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to QP Detector and specified bandwidth with Maximum Hold Mode, and record the maximum value.

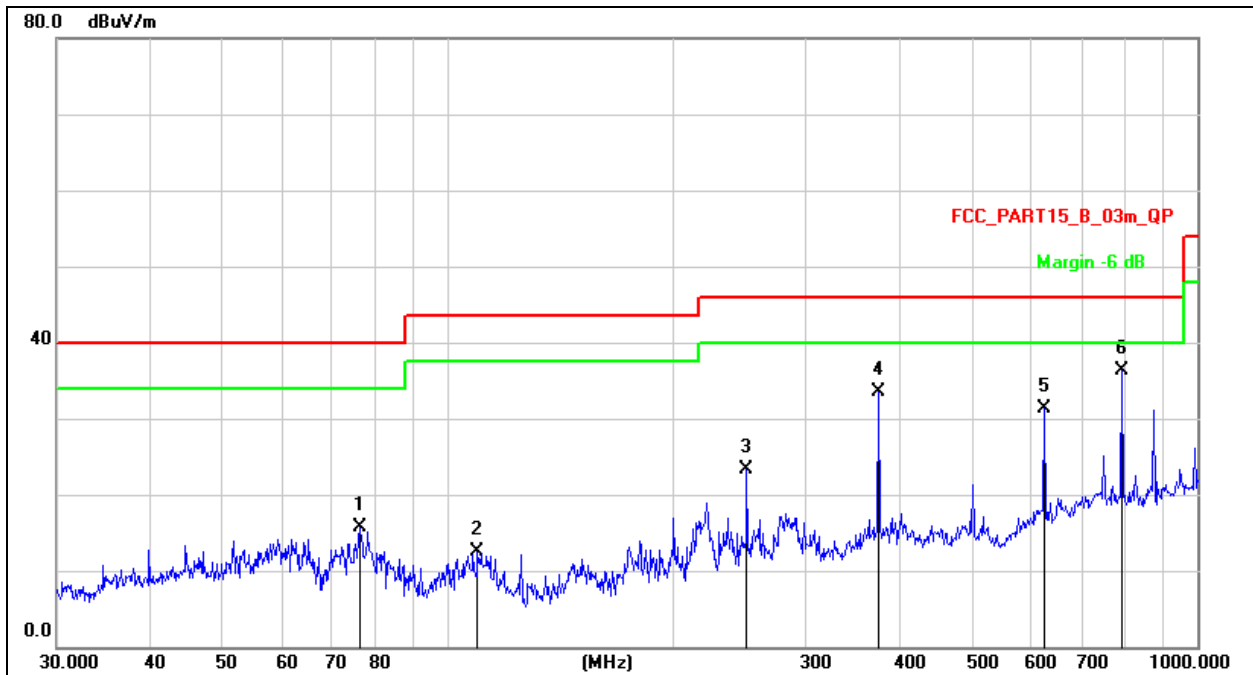
#### Above 1GHz:

- a. The Product was placed on the non-conductive turntable 0.8 m above the ground at a chamber.
- b. Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 1MHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.
- c. For each frequency whose maximum record was higher or close to limit, measure its AV value: rotate the turntable from 0 to 360 degrees to find the degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to AV value and specified bandwidth with Maximum Hold Mode, and record the maximum value.

### 7.4 Test Result

30MHz ~ 1GHz

Temperature:	24.1 °C	Relative Humidity:	50%RH
Pressure:	101KPa	Phase :	Horizontal
Test Voltage :	DC 12V from adapter input AC 120V/60Hz	Test Mode:	Working



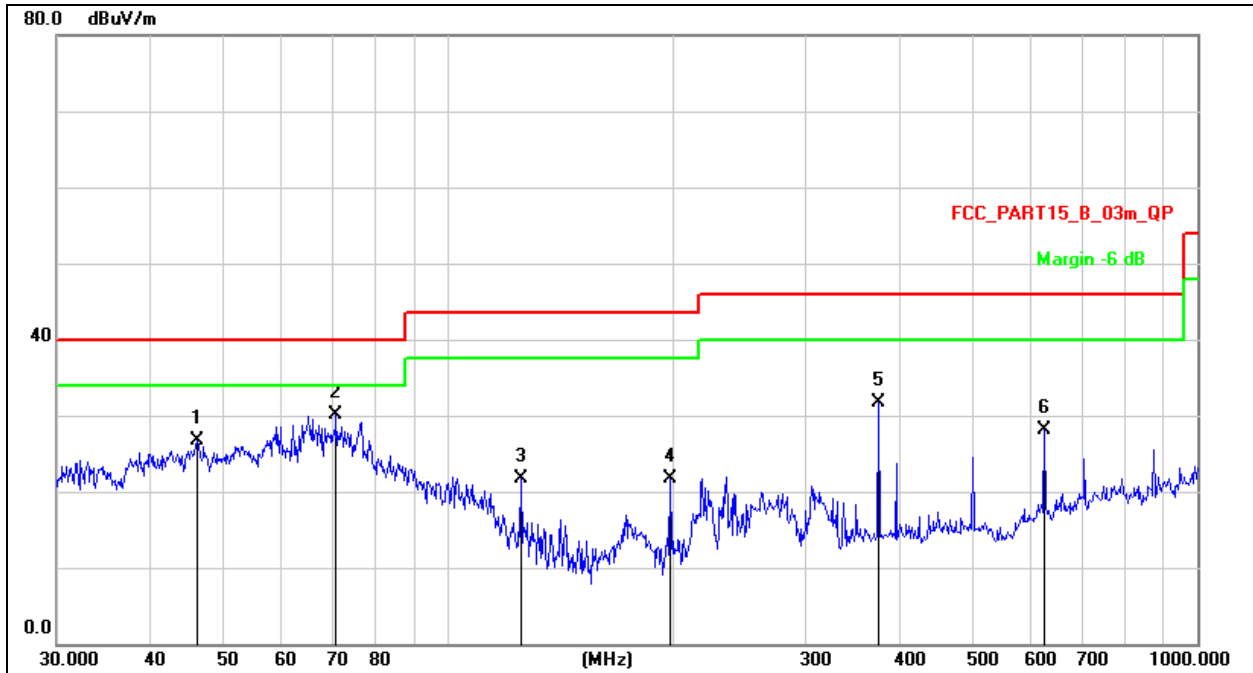
Remark:

1. Factor = Antenna Factor + Cable Loss – Pre-amplifier.
2. Measurement = Reading Level + Correct Factor.
3. Over = Measurement – Limit.

No.	Mk.	Freq.	Reading Level	Correct Factor	Measurement	Limit	Over	Detector
		MHz	dBuV	dB	dBuV/m	dB/m	dB	
1		76.2442	34.83	-19.09	15.74	40.00	-24.26	QP
2		109.4116	29.11	-16.59	12.52	43.50	-30.98	QP
3		250.3012	37.52	-14.28	23.24	46.00	-22.76	QP
4		375.9385	44.69	-11.15	33.54	46.00	-12.46	QP
5		625.0780	37.92	-6.59	31.33	46.00	-14.67	QP
6	*	793.3960	40.75	-4.48	36.27	46.00	-9.73	QP



Temperature:	24.1 °C	Relative Humidity:	50%RH
Pressure:	101KPa	Phase :	Vertical
Test Voltage :	DC 12V from adapter input AC 120V/60Hz	Test Mode:	Working

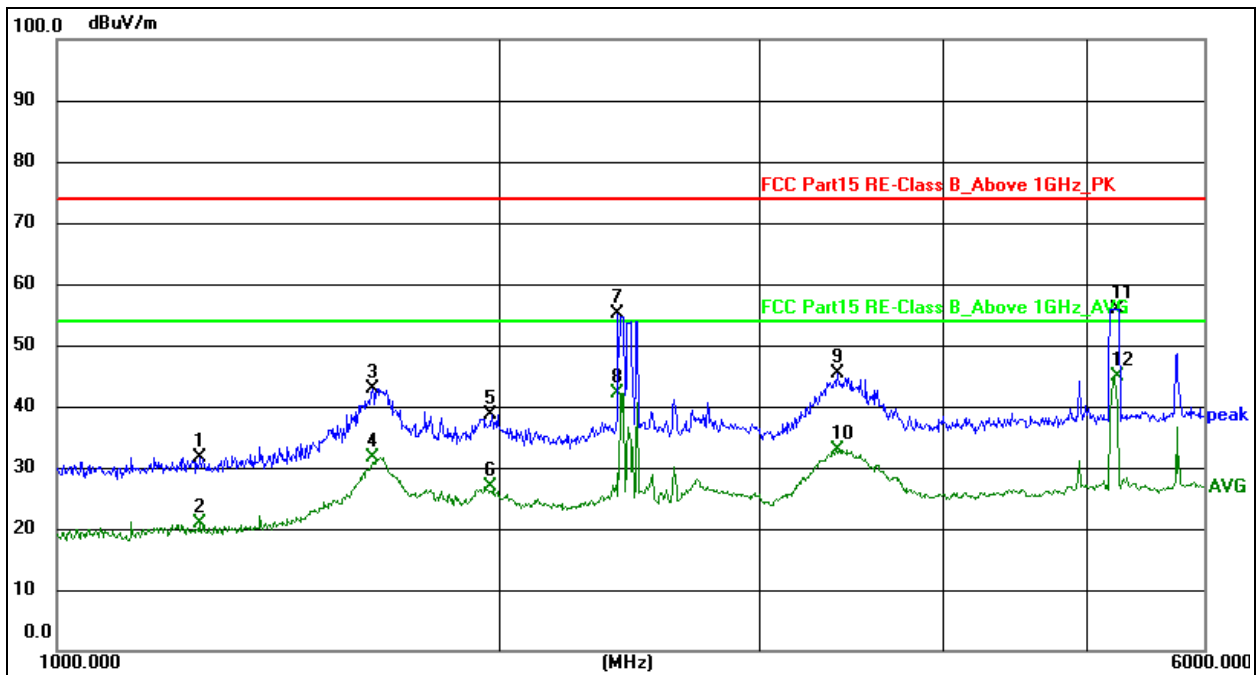

**Remark:**

- Factor = Antenna Factor + Cable Loss – Pre-amplifier.
- Measurement = Reading Level + Correct Factor.
- Over = Measurement – Limit.

No.	Mk.	Freq.	Reading Level	Correct Factor	Measurement	Limit	Over	Detector
		MHz	dBuV	dB	dBuV/m	dB/m	dB	
1		46.1779	40.84	-14.21	26.63	40.00	-13.37	QP
2	*	70.8315	48.35	-18.15	30.20	40.00	-9.80	QP
3		125.0066	39.37	-17.68	21.69	43.50	-21.81	QP
4		197.8928	37.52	-15.88	21.64	43.50	-21.86	QP
5		375.9385	42.80	-11.15	31.65	46.00	-14.35	QP
6		625.0780	34.70	-6.59	28.11	46.00	-17.89	QP

## Above 1GHz

Temperature:	24.2 °C	Relative Humidity:	51%RH
Pressure:	101KPa	Phase :	Horizontal
Test Voltage :	DC 12V from adapter input AC 120V/60Hz	Test Mode:	Working



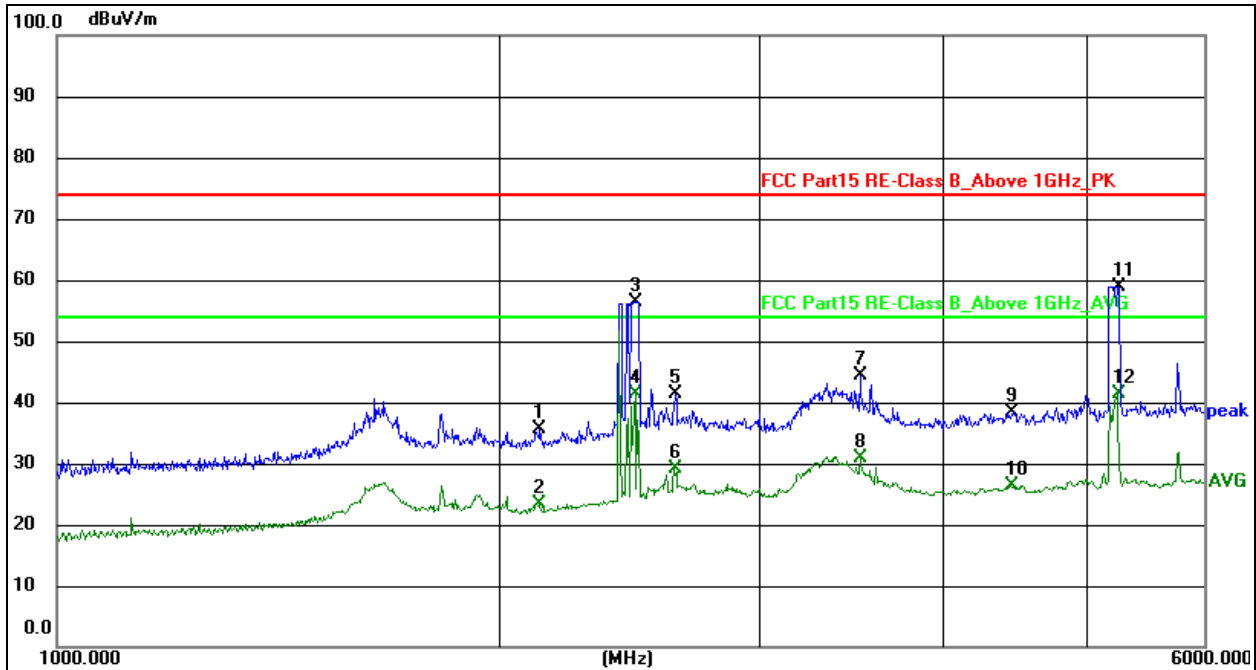
## Remark:

- Factor = Antenna Factor + Cable Loss – Pre-amplifier.
- Measurement = Reading Level + Correct Factor.
- Over = Measurement – Limit.

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector
1	1251.033	60.14	-28.46	31.68	74.00	-42.32	peak
2	1251.033	49.31	-28.46	20.85	54.00	-33.15	AVG
3	1636.785	70.19	-27.23	42.96	74.00	-31.04	peak
4	1636.785	58.76	-27.23	31.53	54.00	-22.47	AVG
5	1972.056	64.89	-26.17	38.72	74.00	-35.28	peak
6	1972.056	53.13	-26.17	26.96	54.00	-27.04	AVG
7	2401.685	80.04	-24.92	55.12	74.00	-18.88	peak
8	2401.685	66.96	-24.92	42.04	54.00	-11.96	AVG
9	3381.761	67.82	-22.54	45.28	74.00	-28.72	peak
10	3381.761	55.51	-22.54	32.97	54.00	-21.03	AVG
11	5236.146	75.09	-19.20	55.89	74.00	-18.11	peak
12 *	5236.146	64.17	-19.20	44.97	54.00	-9.03	AVG

30.LTD

Temperature:	24.2 °C	Relative Humidity:	51%RH
Pressure:	101KPa	Phase :	Vertical
Test Voltage :	DC 12V from adapter input AC 120V/60Hz	Test Mode:	Working


**Remark:**

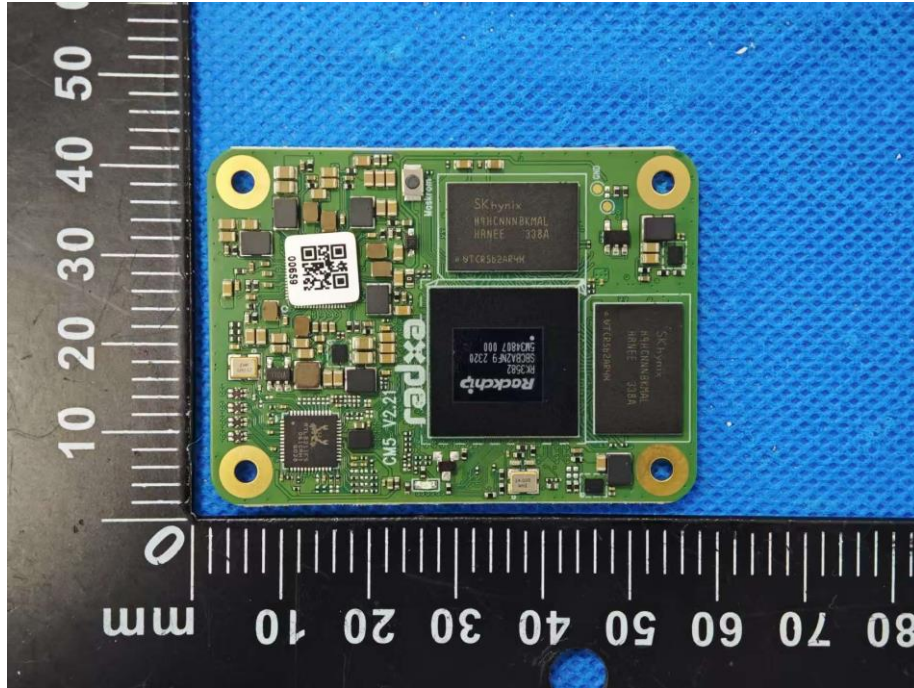
1. Factor = Antenna Factor + Cable Loss – Pre-amplifier.
2. Measurement = Reading Level + Correct Factor.
3. Over = Measurement – Limit.

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector
1	2126.188	61.25	-25.71	35.54	74.00	-38.46	peak
2	2126.188	49.12	-25.71	23.41	54.00	-30.59	AVG
3	2475.965	81.06	-24.70	56.36	74.00	-17.64	peak
4 *	2475.965	66.11	-24.70	41.41	54.00	-12.59	AVG
5	2626.779	65.71	-24.26	41.45	74.00	-32.55	peak
6	2626.779	53.37	-24.26	29.11	54.00	-24.89	AVG
7	3505.144	66.83	-22.33	44.50	74.00	-29.50	peak
8	3505.144	53.28	-22.33	30.95	54.00	-23.05	AVG
9	4456.338	58.84	-20.55	38.29	74.00	-35.71	peak
10	4456.338	46.92	-20.55	26.37	54.00	-27.63	AVG
11	5254.944	78.07	-19.18	58.89	74.00	-15.11	peak
12	5254.944	60.51	-19.18	41.33	54.00	-12.67	AVG

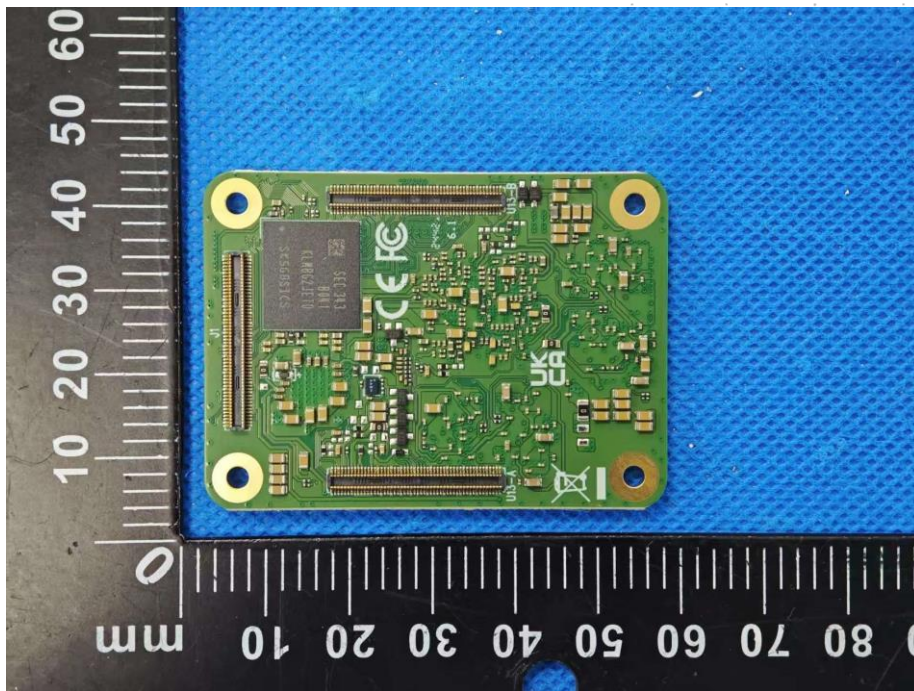


### 8. EUT Photographs

EUT Photo 1



EUT Photo 2



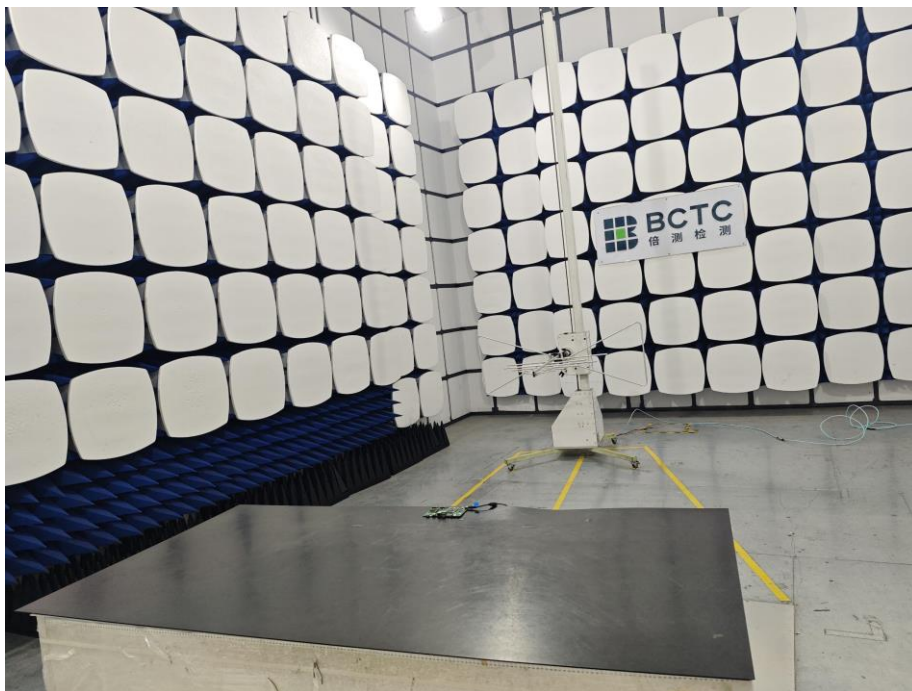


### 9. EUT Test Setup Photographs

Conducted emissions

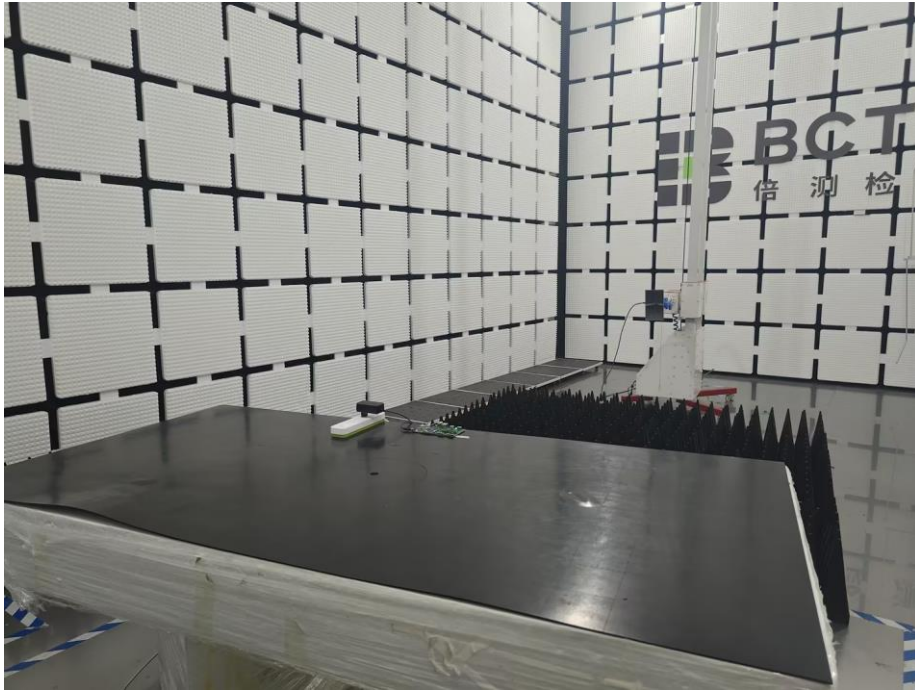


Radiated emissions (30MHz ~ 1GHz)



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Radiated emissions (Above 1GHz)



**STATEMENT**

1. The equipment lists are traceable to the national reference standards.
2. The test report can not be partially copied unless prior written approval is issued from our lab.
3. The test report is invalid without the "special seal for inspection and testing".
4. The test report is invalid without the signature of the approver.
5. The test process and test result is only related to the Unit Under Test.
6. Sample information is provided by the client and the laboratory is not responsible for its authenticity.
7. The quality system of our laboratory is in accordance with ISO/IEC17025.
8. If there is any objection to this test report, the client should inform issuing laboratory within 15 days from the date of receiving test report.

## Address:

1-2/F., Building B, Pengzhou Industrial Park, No.158, Fuyuan 1st Road, Zhancheng, Fuhai Subdistrict, Bao'an District, Shenzhen, Guangdong, China

TEL: 400-788-9558

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